

**Notice of References Cited**

Application/Control No.

10/042,913

Applicant(s)/Patent Under  
Reexamination  
FAN ET AL.

Examiner

Julian Mercado

Art Unit

1745

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-5,464,706	11-1995	Dasgupta et al.	429/218.1
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages
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